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## U.S. UTILITY Patent Application

PATENT NUMBER and ISSUE DATE

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10039333	11/09/2001	216		1746	TIAM, B
**APPLICANT	S: Lee Ge	ne; Kim N	lam-Hun;	• ~	
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**CONTINUIN	G DATA VERIFIEI	D:		÷	
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** FOREIGN A	APPLICATIONS V	ERIFIED:			
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	litions met lowledged Examiners's	⊐ ye intials	es I no es I no		5545 (2616-012)
TITLE : Metho	d for etching tungs	sten using	NF3 and CI2		U.S.DEPT, OF COMM /PAT.& TM-PTO-496L(Rev
					CLAIMS ALLOWED

NOTICE OF ALL	OWANCE MAILED		CLAIMS ALLOWED					
		Assistant Examiner	Total Claims		Print Claim for O.G			
100	UE FEE		DRAWING		DRAW	ING		
Amount Due	Date Paid	1	Shoets Drwg.	Figs.Drwg.	Print Fig			
	<u> </u>	Primary Examiner						
TERMINAL		PREPARED F RISSUE	Application Examiner					
	DISCLAMER	WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.						
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